

UNITED STATES PATENT AND TRADEMARK OFFICE

Examiner: To Be Assigned Art Unit: To be Assigned
Re: Application of: **Albrecht WEISS et al.**
Serial No.: To be Assigned
Filed: Herewith
For: **MICROSCOPE AND MICROSCOPY
METHOD FOR PRODUCING OVERLAY
IMAGES**

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

May 5, 2004

Sir:

In accordance with the provisions of 37 C.F.R. § 1.97, Applicant hereby makes of record the documents listed on the accompanying PTO-1449 Form (1 page) for consideration by the Examiner in connection with the examination of the above-identified patent application. While the references are being submitted herewith, some or all of the references may not constitute prior art under the U.S. patent laws.

The references cited on the accompanying PTO-1449 Form were cited in a German-language European Search Report, a copy of which, along with a brief English translation thereof, is submitted herewith.

5005.1078

In the event any additional fee is due in connection with this response or if any fee has been overpaid, the deficiency or overpayment should be charged to our Deposit Account No. 50-0552.

It is respectfully requested that the references cited in the accompanying PTO-1449 form be considered and made of record. It is respectfully submitted that the pending claims are patentable over all of the references made of record at this time.

Respectfully submitted,
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FORM PTO-1449
(REV. 7-80)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.: 5005.1078

SERIAL NO.: To be Assigned

LIST OF PRIOR ART CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT(S): Albrecht WEISS et al.

FILING DATE: Herewith

GROUP: To be Assigned

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
	AA	20	01	00	40	7	2	3		Nov. 15, 2001	Kusaka	359	370	
	AB	5	6	3	8	2	0	6		Jun. 10, 1997	Sumiya et al.	359	368	
	AC	4	5	1	5	4	4	7		May 7, 1985	Weimer et al.	350	527	
	AD													
	AE													
	AF													
	AG													
	AH													
	AI													

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
														YES	NO
	AJ	3	2	1	4	2	6	8		Oct. 20, 1983	DE-Germany			corresponds to US 4,515,447	
	AK	3	5	4	2	2	1	8		April 7, 1994	DE-Germany			Abstract	
	AJ														
	AK														
	AL														
	AM														
	AN														
	AO														
	AP														

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AR	
AS	
AT	

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.